

FORM PTO-1449	SERIAL NO. <u>10/532894</u> <small>Not yet assigned</small>	CASE NO. 10808/235
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT <small>(use several sheets if necessary)</small>	FILING DATE	GROUP ART UNIT
	Herewith	<u>2823</u> N/A
APPLICANT(S): Josef Böck et al.		

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
	A1	US 2002/0079554 A1	June 27, 2002	Okawa et al.	
	A2	US 2001/0045619 A1	November 29, 2001	Dekker et al.	
	A3	4,882,294	November 21, 1999	Christenson	
	A4	4,379,726	April 12, 1983	Kamamaru et al.	

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
	A5	DE 100 44 838 A1	September 11, 2000	Germany	
	A6	WO 97/17726	May 15, 1997	WO	
	A7	JP 62154779	July 9, 1987	Japan	
	A8	JP 58159346	September 21, 1983	Japan	
	A9	JP 58009354	January 19, 1983	Japan	
	A10	GB 1 480 050	July 20, 1977	Great Britain	
	A11	DE 26 33 569	July 27, 1976	Germany	

EXAMINER INITIAL	OTHER ART - NON PATENT LITERATURE DOCUMENTS <small>(Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.</small>
	A12 Bipolar Transistor with Pedestal Subcollector Regions Self-Aligned Underneath Field Oxide Regions, pgs. 252-253, 700 IBM Technical Disclosure Bulletin, Vol. 31, No. 3, August 1988.
	A13 M. Racanelli, K. Schuegraf, A. Kalburge, A. Kar-Ray, B. Shen, C. Hu, D. Chapek, D. Howard, D. Quon, F. Wang, G. U'ren, L. Lao, J. Zheng, J. Zhang, K. Bell, K. Yin, P. Joshi, S. Akhtar, S. Vo, T. Lee, W. Shi and P. Kempf, <i>Ultra High Speed SiGe NPN for Advanced BiCMOS Technology</i> , Silicon RF Platform Technologies, Conexant Systems, Inc.
	A14 Copy of International Search Report from corresponding PCT patent application number PCT/DE03/03552.
	A15 Copy of Examination Report from corresponding PCT patent application number PCT/DE03/03552.

EXAMINER	DATE CONSIDERED <u>9/28/07</u>
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.